

**Search Notes**

Application/Control No.

10/560,133

Examiner

Hai H. Huynh

Applicant(s)/Patent under  
Reexamination

ODA ET AL.

Art Unit

3747

**SEARCHED**

Class	Subclass	Date	Examiner
123	406.29- 406.3	4/4/2006	HHH
123	304-305	4/4/2006	HHH
123	1A	4/4/2006	HHH
123	27GE	4/4/2006	HHH
123	525	4/4/2006	HHH
123	431	4/4/2006	HHH
123	575	4/4/2006	HHH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
above	search	4/4/2006	HHH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	4/4/2006	HHH